

PEAK VOLTMETERS

Passive circuits are not very frequently used these days for measurement of the peak value of a.c. or impulse voltages. The development of fully integrated operational amplifiers and other electronic circuits has made it possible to sample and hold such voltages and thus make measurements and, therefore, have replaced the conventional passive circuits. However, it is to be noted that if the passive circuits are designed properly, they provide simplicity and adequate accuracy and hence a small description of these circuits is in order. Passive circuits are cheap, reliable and have a high order of electromagnetic compatibility. However, in contrast, the most sophisticated electronic instruments are costlier and their electromagnetic compatibility (EMC) is low. The passive circuits cannot measure high voltages directly and use potential dividers preferably of the capacitance type. Fig. 4.4.1 shows a simple peak voltmeter circuit consisting of a capacitor voltage divider which reduces the voltage V to be measured to a low voltage V_m .

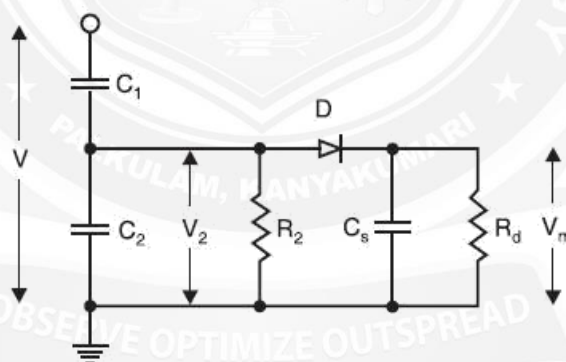


Figure 4.4.1 Peak voltmeter

Source: "High Voltage Engineering" by C.L. Wadhwa , Page – 603]

Suppose R_2 and R_d are not present and the supply voltage is V . The voltage across the storage capacitor C_s will be equal to the peak value of voltage across C_2 assuming voltage drop across the diode to be negligibly small. The voltage could be measured by an electrostatic voltmeter or other suitable voltmeters with very high input impedance. If the reverse current through the diode is very small and the discharge time constant of the

storage capacitor very large, the storage capacitor will not discharge significantly for a long time and hence it will hold the voltage to its value for a long time. If now, V is decreased, the voltage V_2 decreases proportionately and since now the voltage across C_2 is smaller than the voltage across C_s to which it is already charged, therefore, the diode does not conduct and the voltage across C_s does not follow the voltage across C_2 . Hence, a discharge resistor R_d must be introduced into the circuit so that the voltage across C_s follows the voltage across C_2 . From measurement point of view it is desirable that the quantity to be measured should be indicated by the meter within a few seconds and hence R_d is so chosen that $R_d C_s \approx 1$ sec. As a result of this, following errors are introduced. With the connection of R_d , the voltage across C_s will decrease continuously even when the input voltage is kept constant. Also, it will discharge the capacitor C_2 and the mean potential of $V_2(t)$ will gain a negative d.c component. Hence a leakage resistor R_2 must be inserted in parallel with C_2 to equalize these unipolar discharge currents. The second error corresponds to the voltage shape across the storage capacitor which contains ripple and is due to the discharge of the capacitor C_s . If the input impedance of the measuring device is very high, the ripple is independent of the meter being used. The error is approximately proportional to the ripple factor and is thus frequency dependent as the discharge time constant cannot be changed. If $R_d C_s = 1$ sec, the discharge error amounts to 1% for 50 Hz and 0.33% for 150 Hz. The third source of error is related to this discharge error. During the conduction time (when the voltage across C_s is lower than that across C_2 because of discharge of C_s through R_d) of the diode the storage capacitor C_s is recharged to the peak value and thus C_s becomes parallel with C_2 . If discharge error is e_d , recharge error e_r is given by

Hence C_s should be small as compared with C_2 to keep down the recharge error. It has also been observed that in order to keep the overall error to a low value, it is desirable to have a high value of R_2 . The same effect can be obtained by providing an equalizing arm to the low voltage arm of the voltage divider as shown in Fig. 4.4.2 This is accomplished by the addition of a second network comprising diode, C_s and R_d for negative polarity currents to the circuit shown in Fig.4.4.3 With this, the d.c currents in both branches are opposite in polarity and equalize each other. The errors due to R_2 are

thus eliminated. Rabus developed another circuit shown in Figure to reduce errors due to resistances. Two storage capacitors are connected by a resistor R_s within every branch and both are discharged by only one resistance R_d .

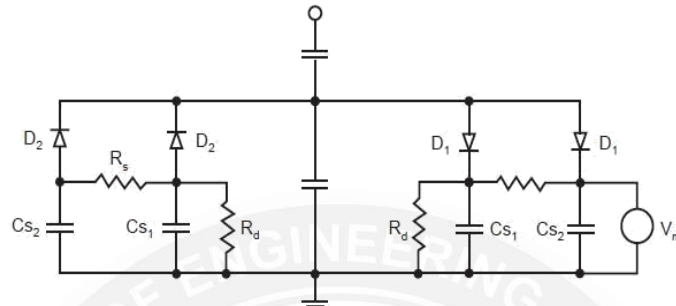


Figure 4.4.2 Two-way booster circuit designed by Rabus

Source: "High Voltage Engineering" by C.L. Wadhwa, Page – 610]

Here because of the presence of R_s , the discharge of the storage capacitor C_{s2} is delayed and hence the inherent discharge error is reduced. However, since these are two storage capacitors within one branch, they would draw more charge from the capacitor C_2 and hence the recharge error would increase. It is, therefore, a matter of designing various elements in the circuit so that the total sum of all the errors is a minimum. It has been observed that with the commonly used circuit elements in the voltage dividers, the error can be kept to well within about 1% even for frequencies below 20 Hz. The capacitor C_1 has to withstand high voltage to be measured and is always placed within the test area whereas the low voltage arm C_2 including the peak circuit and instrument form a measuring unit located in the control area. Hence a coaxial cable is always required to connect the two areas. The cable capacitance comes parallel with the capacitance C_2 which is usually changed in steps if the voltage to be measured is changed. A change of the length of the cable would, thus, also require recalibration of the system. The sheath of the coaxial cable picks up the electrostatic fields and thus prevents the penetration of this field to the core of the conductor. Also, even though transient magnetic fields will penetrate into the core of the cable, no appreciable voltage (extraneous of noise) is induced due to the symmetrical arrangement and hence a coaxial cable provides a good connection between the two areas. Whenever, a discharge takes place at the high voltage end of capacitor C_1 to the cable connection where the current looks into a change

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